

8 03

V_{CC} = Pin 4 GND = Pin 10

Output Loading Factor (MTTL I Loads): $MC4337 = 10 (I_{OL} = 13.3 mAdc)$ $MC4037 = 10 (I_{OL} = 16.6 mAdc)$ Total Power Dissipation = 150 mW typ/pkg Propagation Delay Time = 25 ns typ





SWITCHING TIME TEST CIRCUIT



MC4337F,L, MC4037F,L,P (continued)



VOLTAGE WAVEFORMS

SWITCHING TIME TEST PROCEDURES (T_A = 25° C) (Letters shown in test columns refer to waveforms.)

		PIN	IN	PUT	OUTPUT		
TEST	SYMBOL	UNDER TEST (In/Out)	Pin 1 D0	Pin 2 Strobe	Pin 14 Q0	LIMITS (ns) Max	
Strobe Propagation Delay	^t pd+1	2/14	w	v	×	25	
	tpd-1	2/14	w	v	×	40	
Rise Time	t+	14	w	v	×	8.0	
Fall Time	t-	14	w	v	×	5.0	
Data Propagation Delay	^t pd+2	1/14	Y	2.4 V	z	20	
	tpd-2	1/14	Y	2.4 V	z	30	
Minimum Strobe Enable	-	1/14	w①	1.8 V	3	2	
Maximum Strobe Inhibit	-	1/14	w①	1.0 V	3)	3	

MC4337F,L, MC4037F,L,P (continued)

Γ									, 10	0,10				4					7, 10	
							Gnd	°.→	2,10 1,3,5,7,10	2,10 1,3,5,7,10		10	10	10,14	10		10	10	1, 3, 5, 7, 10	
						Dulca							1	•	•			•		
Pulse 1								1.1.1				1 61	•		•			a.		
tures)		Vcch	5.5	5.25	ÿ		VccH	4-	4 4	44			,	4	4		1	۰.	-	-
		VccL	4.5	4.75			CCL					44	4	1	1		1	'		
		< د در	5.0	5.0			200		1.1			• •	1	1	•		1	4	4	
empera		Vmax	7.0	7.0	STED		Vmax		2.1	1.1		1.1	1	1	•		4	1	,	
(All T	Volts	Vout	5.5	5.5	PINS		V out			• •				,	14		•	1		
TEST CURRENT / VOLTAGE VALUES (All Temperatures)		V _R	4.5	4.5	PLIED TO		>"	2 3,5,7 1,3,5,7	5 1				•	1	1,2		73	,		
OLTAG		ζ,	0.4	0.4	GE API		>"	5 1 1		1.1		1.1					1	1	1	
NT / V(۲	2.0	2.0	VOLTA		>#					~ 1	1,2	1			4	1		
CURRE		V _{IL}	0.8	0.8	RENT		ν,	1 2 1					1	1	•		1	•	1	
TEST	mA	_5	1.0	1.0	ST CUR		s		1.1	1 2		1.1	i.	1	•		i.	•		
		Чон	-1.4	-1.4	E		-ы	ų i i	1.1	1 1		· i i	14	1	1		1	1	1	
		1º1	13.3	13.3			-10	1.1.1		• •		14 14	1	1	•		•	•	1	
			MC4337	MC4037			Unit	mAdc	mAdc mAdc	Vdc Vdc		Vdc Vdc	Vdc	mAdc	mAdc		mAdc	mAdc	mAdc	
						+75°C	Max	-6.7 -1.8 -8.6	0.5	1.1		0.4	1	-60	0.25		1	32	55	
				MC4037 Test Limits	+	Min		1.1				2.4	-15	1		1	1	T		
					+25°C	Max	-6.7 -1.8 -8.6	0.2	ъ.)		0.4	•	-60	0.25		20	32	55		
					MC40	+	2		1.1	5.5		1.1	2.4	-15	1		1	,	1	
						0°C	Max	-6.7 -1.8 -8.6	0.5	1.1		0.4	1	-60	0.25		Т.	32	55	
							Ň			1.1			2.4	-15	1		1	1	1	
						+25°C +125°C	Max	-5.6 -1.5 -7.0	0.5			0.4	•	-60	0.25		5.1 -	26	45	
					nits		-	111		1.1	1	1-1	2.4	-15	1	1	1	1	1.	
					Test Lii		Max	-5.6 -1.5 -7.0	0.5	1.1		0.4	1	-60	0.25		40	26	45	
					MC4337 Test Limits	Ŧ	-	5.00	1.1	5.5		si i	2.4	-15	1		- 1-	٩.,	1	5 5-5, 8, 8
					Ň	-55°C	Max	-5.6 -1.5 -7.0	0.5			0.4	r	-60	0.25			26	45	
						1	Z	111	4.1	1.1.	1.1	1.1	2.4	-15				•	•	
					ż	Pin Under Symbol Test			- 01	7 7	1	14 14	14	14	14		4	4	4	
								I	IR	BV _{in}		V _{OL}	V _{OH}	Isc	I _{CEX}		Imax	HOd	Ipdl	2.4 V 0.8 V 0.8 V 2.4 V 0 V min
							Characteristic	Input Forward Current	Leakage Current	Breakdown Voltage	Output	Output Voltage		Short-Circuit Current	Leakage Current	Power Requirements (Total Device)	Maximum Power Supply Current	Power Supply Drain		Pulse: 1

ELECTRICAL CHARACTERISTICS

Test procedures are shown for only the Strobe input, one data input, and one out-put. Other data inputs and outputs are tested in the same manner.